

### FEATURES

**Fast Throughput Rate: 200 kSPS**

**Specified for  $AV_{DD}$  of 2.7 V to 5.25 V**

**Low Power:**

**3.6 mW Max at 200 kSPS with 3 V Supply**

**7.5 mW Max at 200 kSPS with 5 V Supply**

**8 (Single-Ended) Inputs with Sequencer**

**Wide Input Bandwidth:**

**70 dB Min SINAD at 50 kHz Input Frequency**

**Flexible Power/Serial Clock Speed Management**

**No Pipeline Delays**

**High Speed Serial Interface SPI™/QSPI™/**

**MICROWIRE™/DSP Compatible**

**Shutdown Mode: 0.5  $\mu$ A Max**

**20-Lead TSSOP Package**

### GENERAL DESCRIPTION

The AD7927 is a 12-bit, high speed, low power, 8-channel, successive-approximation ADC. The part operates from a single 2.7 V to 5.25 V power supply and features throughput rates up to 200 kSPS. The part contains a low noise, wide bandwidth track-and-hold amplifier that can handle input frequencies in excess of 8 MHz.

The conversion process and data acquisition are controlled using  $\overline{CS}$  and the serial clock signal, allowing the device to easily interface with microprocessors or DSPs. The input signal is sampled on the falling edge of  $\overline{CS}$  and the conversion is also initiated at this point. There are no pipeline delays associated with the part.

The AD7927 uses advanced design techniques to achieve very low power dissipation at maximum throughput rates. At maximum throughput rates, the AD7927 consumes 1.2 mA maximum with 3 V supplies; with 5 V supplies, the current consumption is 1.5 mA maximum.

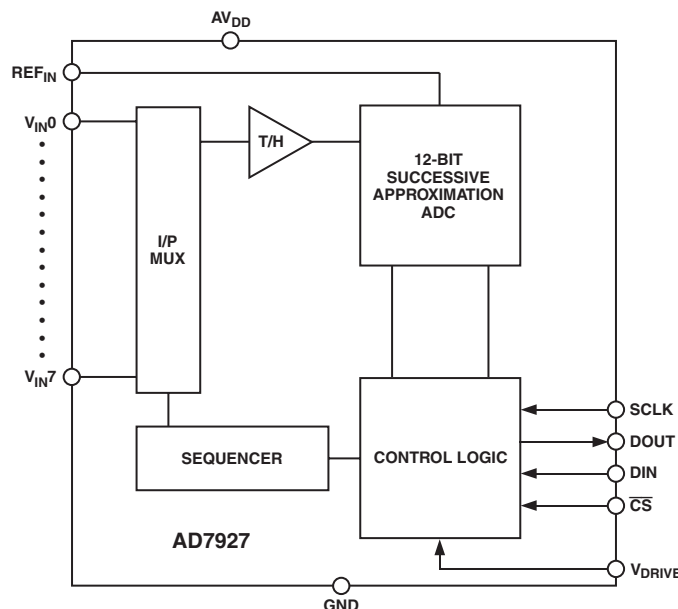
Through the configuration of the Control Register, the analog input range for the part can be selected as 0 V to  $REF_{IN}$  or 0 V to  $2 \times REF_{IN}$ , with either straight binary or twos complement output coding. The AD7927 features eight single-ended analog inputs with a channel sequencer to allow a preprogrammed selection of channels to be converted sequentially.

The conversion time for the AD7927 is determined by the SCLK frequency, as this is also used as the master clock to control the conversion. The conversion time may be as short as 800 ns with a 20 MHz SCLK.

REV. 0

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### FUNCTIONAL BLOCK DIAGRAM



### PRODUCT HIGHLIGHTS

- High Throughput with Low Power Consumption.**  
The AD7927 offers up to 200 kSPS throughput rates. At the maximum throughput rate with 3 V supplies, the AD7927 dissipates 3.6 mW of power maximum.
- Eight Single-Ended Inputs with a Channel Sequencer.**  
A consecutive sequence of channels, through which the ADC will cycle and convert on, can be selected.
- Single-Supply Operation with  $V_{DRIVE}$  Function.**  
The AD7927 operates from a single 2.7 V to 5.25 V supply. The  $V_{DRIVE}$  function allows the serial interface to connect directly to either 3 V or 5 V processor systems independent of  $AV_{DD}$ .
- Flexible Power/Serial Clock Speed Management.**  
The conversion rate is determined by the serial clock, allowing the conversion time to be reduced through the serial clock speed increase. The part also features various shutdown modes to maximize power efficiency at lower throughput rates. Current consumption is 0.5  $\mu$ A maximum when in full shutdown.
- No Pipeline Delay.**  
The part features a standard successive-approximation ADC with accurate control of the sampling instant via a  $\overline{CS}$  input and once off conversion control.

# AD7927—SPECIFICATIONS ( $AV_{DD} = V_{DRIVE} = 2.7\text{ V}$ to $5.25\text{ V}$ , $REF_{IN} = 2.5\text{ V}$ , $f_{SCLK} = 20\text{ MHz}$ , $T_A = T_{MIN}$ to $T_{MAX}$ , unless otherwise noted.)

Parameter	B Version <sup>1</sup>	Unit	Test Conditions/Comments
<b>DYNAMIC PERFORMANCE</b>			
Signal-to-(Noise + Distortion) (SINAD) <sup>2</sup>	70	dB min	$f_{IN} = 50\text{ kHz}$ Sine Wave, $f_{SCLK} = 20\text{ MHz}$ @ 5 V
Signal-to-Noise Ratio (SNR) <sup>2</sup>	69	dB min	@ 3 V Typically 70 dB
Total Harmonic Distortion (THD) <sup>2</sup>	70	dB min	
	–77	dB max	@ 5 V Typically –84 dB
	–73	dB max	@ 3 V Typically –77 dB
Peak Harmonic or Spurious Noise (SFDR) <sup>2</sup>	–78	dB max	@ 5 V Typically –86 dB
	–76	dB max	@ 3 V Typically –80 dB
Intermodulation Distortion (IMD) <sup>2</sup>			$f_a = 40.1\text{ kHz}$ , $f_b = 41.5\text{ kHz}$
Second Order Terms	–90	dB typ	
Third Order Terms	–90	dB typ	
Aperture Delay	10	ns typ	
Aperture Jitter	50	ps typ	
Channel-to-Channel Isolation <sup>2</sup>	–82	dB typ	$f_{IN} = 400\text{ kHz}$
Full Power Bandwidth	8.2	MHz typ	@ 3 dB
	1.6	MHz typ	@ 0.1 dB
<b>DC ACCURACY<sup>2</sup></b>			
Resolution	12	Bits	
Integral Nonlinearity	±1	LSB max	
Differential Nonlinearity	–0.9/+1.5	LSB max	Guaranteed No Missed Codes to 12 Bits
0 V to $REF_{IN}$ Input Range			Straight Binary Output Coding
Offset Error	±8	LSB max	Typically ±0.5 LSB
Offset Error Match	±0.5	LSB max	
Gain Error	±1.5	LSB max	
Gain Error Match	±0.5	LSB max	
0 V to $2 \times REF_{IN}$ Input Range			– $REF_{IN}$ to + $REF_{IN}$ Biased about $REF_{IN}$ with
Positive Gain Error	±1.5	LSB max	Twos Complement Output Coding
Positive Gain Error Match	±0.5	LSB max	
Zero Code Error	±8	LSB max	Typically ±0.8 LSB
Zero Code Error Match	±0.5	LSB max	
Negative Gain Error	±1	LSB max	
Negative Gain Error Match	±0.5	LSB max	
<b>ANALOG INPUT</b>			
Input Voltage Ranges	0 to $REF_{IN}$	V	RANGE Bit Set to 1
	0 to $2 \times REF_{IN}$	V	RANGE Bit Set to 0, $AV_{DD}/V_{DRIVE} = 4.75\text{ V}$ to $5.25\text{ V}$
DC Leakage Current	±1	μA max	
Input Capacitance	20	pF typ	$f_{SAMPLE} = 200\text{ kSPS}$
<b>REFERENCE INPUT</b>			
$REF_{IN}$ Input Voltage	2.5	V	±1% Specified Performance
DC Leakage Current	±1	μA max	
$REF_{IN}$ Input Impedance	36	kΩ typ	
<b>LOGIC INPUTS</b>			
Input High Voltage, $V_{INH}$	$0.7 \times V_{DRIVE}$	V min	
Input Low Voltage, $V_{INL}$	$0.3 \times V_{DRIVE}$	V max	
Input Current, $I_{IN}$	±1	μA max	Typically 10 nA, $V_{IN} = 0\text{ V}$ or $V_{DRIVE}$
Input Capacitance, $C_{IN}^3$	10	pF max	
<b>LOGIC OUTPUTS</b>			
Output High Voltage, $V_{OH}$	$V_{DRIVE} - 0.2$	V min	$I_{SOURCE} = 200\text{ μA}$ , $AV_{DD} = 2.7\text{ V}$ to $5.25\text{ V}$
Output Low Voltage, $V_{OL}$	0.4	V max	$I_{SINK} = 200\text{ μA}$
Floating-State Leakage Current	±1	μA max	
Floating-State Output Capacitance <sup>3</sup>	10	pF max	
Output Coding	Straight (Natural) Binary		Coding Bit Set to 1
	Twos Complement		Coding Bit Set to 0

Parameter	B Version <sup>1</sup>	Unit	Test Conditions/Comments
<b>CONVERSION RATE</b>			
Conversion Time	800	ns max	16 SCLK Cycles with SCLK at 20 MHz
Track-and-Hold Acquisition Time	300	ns max	Sine Wave Input
	300	ns max	Full-Scale Step Input
Throughput Rate	200	kSPS max	See Serial Interface Section
<b>POWER REQUIREMENTS</b>			
$V_{DD}$	2.7/5.25	V min/max	Digital I/Ps = 0 V or $V_{DRIVE}$
$V_{DRIVE}$	2.7/5.25	V min/max	
$I_{DD}$ <sup>4</sup>			
During Conversion	2.7	mA max	$AV_{DD} = 4.75$ V to 5.25 V, $f_{SCLK} = 20$ MHz
	2	mA max	$AV_{DD} = 2.7$ V to 3.6 V, $f_{SCLK} = 20$ MHz
Normal Mode (Static)	600	$\mu$ A typ	$AV_{DD} = 2.7$ V to 5.25 V, SCLK On or Off
Normal Mode (Operational) $f_{SAMPLE} = 200$ kSPS	1.5	mA max	$AV_{DD} = 4.75$ V to 5.25 V, $f_{SCLK} = 20$ MHz
	1.2	mA max	$AV_{DD} = 2.7$ V to 3.6 V, $f_{SCLK} = 20$ MHz
Using Auto Shutdown Mode $f_{SAMPLE} = 200$ kSPS	900	$\mu$ A typ	$AV_{DD} = 4.75$ V to 5.25 V, $f_{SCLK} = 20$ MHz
	650	$\mu$ A typ	$AV_{DD} = 2.7$ V to 3.6 V, $f_{SCLK} = 20$ MHz
Auto Shutdown (Static)	0.5	$\mu$ A max	SCLK On or Off (20 nA typ)
Full Shutdown Mode	0.5	$\mu$ A max	SCLK On or Off (20 nA typ)
Power Dissipation <sup>4</sup>			
Normal Mode (Operational)	7.5	mW max	$AV_{DD} = 5$ V, $f_{SCLK} = 20$ MHz
	3.6	mW max	$AV_{DD} = 3$ V, $f_{SCLK} = 20$ MHz
Auto Shutdown (Static)	2.5	$\mu$ W max	$AV_{DD} = 5$ V
	1.5	$\mu$ W max	$AV_{DD} = 3$ V
Full Shutdown Mode	2.5	$\mu$ W max	$AV_{DD} = 5$ V
	1.5	$\mu$ W max	$AV_{DD} = 3$ V

## NOTES

<sup>1</sup>Temperature ranges as follows: B Version:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .<sup>2</sup>See Terminology section.<sup>3</sup>Sample tested @  $25^{\circ}\text{C}$  to ensure compliance.<sup>4</sup>See Power versus Throughput Rate section.

Specifications subject to change without notice.

# TIMING SPECIFICATIONS<sup>1</sup> ( $AV_{DD} = 2.7\text{ V to }5.25\text{ V}$ , $V_{DRIVE} \leq AV_{DD}$ , $REF_{IN} = 2.5\text{ V}$ , $T_A = T_{MIN}$ to $T_{MAX}$ , unless otherwise noted.)

Parameter	Limit at $T_{MIN}$ , $T_{MAX}$ AD7927			Description
	$AV_{DD} = 3\text{ V}$	$AV_{DD} = 5\text{ V}$	Unit	
$f_{SCLK}^2$	10 20	10 20	kHz min MHz max	
$t_{CONVERT}$	$16 \times t_{SCLK}$	$16 \times t_{SCLK}$		
$t_{QUIET}$	50	50	ns min	Minimum Quiet Time Required between $\overline{CS}$ Rising Edge and Start of Next Conversion
$t_2$	10	10	ns min	$\overline{CS}$ to SCLK Setup Time
$t_3^3$	35	30	ns max	Delay from $\overline{CS}$ until DOUT Three-State Disabled
$t_4^3$	40	40	ns max	Data Access Time after SCLK Falling Edge
$t_5$	$0.4 \times t_{SCLK}$	$0.4 \times t_{SCLK}$	ns min	SCLK Low Pulsewidth
$t_6$	$0.4 \times t_{SCLK}$	$0.4 \times t_{SCLK}$	ns min	SCLK High Pulsewidth
$t_7$	10	10	ns min	SCLK to DOUT Valid Hold Time
$t_8^4$	15/45	15/35	ns min/max	SCLK Falling Edge to DOUT High Impedance
$t_9$	10	10	ns min	DIN Setup Time Prior to SCLK Falling Edge
$t_{10}$	5	5	ns min	DIN Hold Time after SCLK Falling Edge
$t_{11}$	20	20	ns min	Sixteenth SCLK Falling Edge to $\overline{CS}$ High
$t_{12}$	1	1	$\mu\text{s}$ max	Power-Up Time from Full Power-Down/Auto Shutdown Mode

## NOTES

<sup>1</sup>Sample tested at 25°C to ensure compliance. All input signals are specified with  $t_r = t_f = 5\text{ ns}$  (10% to 90% of  $AV_{DD}$ ) and timed from a voltage level of 1.6 V.

See Figure 1. The 3 V operating range spans from 2.7 V to 3.6 V. The 5 V operating range spans from 4.75 V to 5.25 V.

<sup>2</sup>Mark/Space ratio for the SCLK input is 40/60 to 60/40.

<sup>3</sup>Measured with the load circuit of Figure 1 and defined as the time required for the output to cross 0.4 V or  $0.7 \times V_{DRIVE}$ .

<sup>4</sup> $t_8$  is derived from the measured time taken by the data outputs to change 0.5 V when loaded with the circuit of Figure 1. The measured number is then extrapolated back to remove the effects of charging or discharging the 50 pF capacitor. This means the time, quoted in the timing characteristics  $t_8$ , is the true bus relinquish time of the part and is independent of the bus loading.

Specifications subject to change without notice.

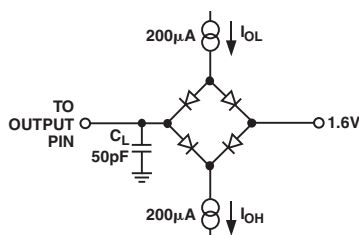


Figure 1. Load Circuit for Digital Output Timing Specifications

**ABSOLUTE MAXIMUM RATINGS<sup>1</sup>**(T<sub>A</sub> = 25°C, unless otherwise noted.)

AV <sub>DD</sub> to AGND	−0.3 V to +7 V
V <sub>DRIVE</sub> to AGND	−0.3 V to AV <sub>DD</sub> + 0.3 V
Analog Input Voltage to AGND	−0.3 V to AV <sub>DD</sub> + 0.3 V
Digital Input Voltage to AGND	−0.3 V to +7 V
Digital Output Voltage to AGND	−0.3 V to AV <sub>DD</sub> + 0.3 V
REF <sub>IN</sub> to AGND	−0.3 V to AV <sub>DD</sub> + 0.3 V
Input Current to Any Pin Except Supplies <sup>2</sup>	±10 mA
Operating Temperature Range	
Commercial (B Version)	−40°C to +85°C
Storage Temperature Range	−65°C to +150°C
Junction Temperature	150°C

TSSOP Package, Power Dissipation	450 mW
θ <sub>JA</sub> Thermal Impedance	143°C/W (TSSOP)
θ <sub>JC</sub> Thermal Impedance	45°C/W (TSSOP)
Lead Temperature, Soldering	
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C
ESD	2 kV

**NOTES**

<sup>1</sup> Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>2</sup> Transient currents of up to 100 mA will not cause SCR latch-up.

**ORDERING GUIDE**

Model	Temperature Range	Linearity Error (LSB) <sup>1</sup>	Package Option	Package Description
AD7927BRU EVAL-AD7927CB <sup>2</sup> EVAL-CONTROL BRD2 <sup>3</sup>	−40°C to +85°C	±1	RU-20	TSSOP Evaluation Board Controller Board

**NOTES**

<sup>1</sup> Linearity error here refers to integral linearity error.

<sup>2</sup> This can be used as a standalone evaluation board or in conjunction with the Evaluation Controller Board for evaluation/demonstration purposes.

<sup>3</sup> This board is a complete unit allowing a PC to control and communicate with all Analog Devices evaluation boards ending in the CB designators. To order a complete evaluation kit, you will need to order the particular ADC evaluation board, e.g., EVAL-AD7927CB, the EVAL-CONTROL BRD2, and a 12 V ac transformer. See the relevant Evaluation Board Application Note for more information.

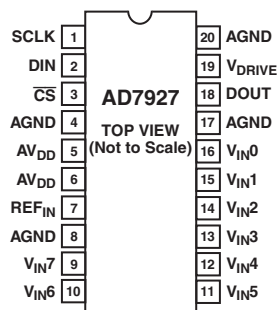
**CAUTION**

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD7927 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



### PIN CONFIGURATION

#### 20-Lead TSSOP



### PIN FUNCTION DESCRIPTIONS

Pin No.	Mnemonic	Function
1	SCLK	Serial Clock. Logic input. SCLK provides the serial clock for accessing data from the part. This clock input is also used as the clock source for the AD7927s conversion process.
2	DIN	Data In. Logic input. Data to be written to the AD7927s Control Register is provided on this input and is clocked into the register on the falling edge of SCLK (see the Control Register section).
3	$\overline{\text{CS}}$	Chip Select. Active low logic input. This input provides the dual function of initiating conversions on the AD7927 and framing the serial data transfer.
4, 8, 17, 20	AGND	Analog Ground. Ground reference point for all analog circuitry on the AD7927. All analog input signals and any external reference signal should be referred to this AGND voltage. All AGND pins should be connected together.
5, 6	AV <sub>DD</sub>	Analog Power Supply Input. The AV <sub>DD</sub> range for the AD7927 is from 2.7 V to 5.25 V. For the 0 V to $2 \times \text{REF}_{\text{IN}}$ range, AV <sub>DD</sub> should be from 4.75 V to 5.25 V.
7	REF <sub>IN</sub>	Reference Input for the AD7927. An external reference must be applied to this input. The voltage range for the external reference is $2.5 \text{ V} \pm 1\%$ for specified performance.
16–9	V <sub>IN0</sub> –V <sub>IN7</sub>	Analog Input 0 through Analog Input 7. Eight single-ended analog input channels that are multiplexed into the on-chip track-and-hold. The analog input channel to be converted is selected by using the address bits ADD2 through ADD0 of the Control Register. The address bits in conjunction with the SEQ and SHADOW bits allow the sequencer to be programmed. The input range for all input channels can extend from 0 V to REF <sub>IN</sub> or 0 V to $2 \times \text{REF}_{\text{IN}}$ , as selected via the RANGE bit in the Control Register. Any unused input channels should be connected to AGND to avoid noise pickup.
18	DOUT	Data Out. Logic output. The conversion result from the AD7927 is provided on this output as a serial data stream. The bits are clocked out on the falling edge of the SCLK input. The data stream from the AD7927 consists of two leading zeros, two address bits indicating which channel the conversion result corresponds to, followed by the 12 bits of conversion data, MSB first. The output coding may be selected as straight binary or twos complement via the CODING bit in the Control Register.
19	V <sub>DRIVE</sub>	Logic Power Supply Input. The voltage supplied at this pin determines at what voltage the serial interface of the AD7927 will operate.

## TERMINOLOGY

### Integral Nonlinearity

This is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are zero-scale, a point 1 LSB below the first code transition, and full-scale, a point 1 LSB above the last code transition.

### Differential Nonlinearity

This is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

### Offset Error

This is the deviation of the first code transition (00 . . . 000) to (00 . . . 001) from the ideal, i.e., AGND + 1 LSB.

### Offset Error Match

This is the difference in offset error between any two channels.

### Gain Error

This is the deviation of the last code transition (111 . . . 110) to (111 . . . 111) from the ideal (i.e.,  $\text{REF}_{\text{IN}} - 1 \text{ LSB}$ ) after the offset error has been adjusted out.

### Gain Error Match

This is the difference in gain error between any two channels.

### Zero Code Error

This applies when using the twos complement output coding option, in particular to the  $2 \times \text{REF}_{\text{IN}}$  input range with  $-\text{REF}_{\text{IN}}$  to  $+\text{REF}_{\text{IN}}$  biased about the  $\text{REF}_{\text{IN}}$  point. It is the deviation of the midscale transition (all 0s to all 1s) from the ideal  $V_{\text{IN}}$  voltage, i.e.,  $\text{REF}_{\text{IN}} - 1 \text{ LSB}$ .

### Zero Code Error Match

This is the difference in Zero Code Error between any two channels.

### Positive Gain Error

This applies when using the twos complement output coding option, in particular to the  $2 \times \text{REF}_{\text{IN}}$  input range with  $-\text{REF}_{\text{IN}}$  to  $+\text{REF}_{\text{IN}}$  biased about the  $\text{REF}_{\text{IN}}$  point. It is the deviation of the last code transition (011 . . . 110) to (011 . . . 111) from the ideal (i.e.,  $+\text{REF}_{\text{IN}} - 1 \text{ LSB}$ ) after the Zero Code Error has been adjusted out.

### Positive Gain Error Match

This is the difference in Positive Gain Error between any two channels.

### Negative Gain Error

This applies when using the twos complement output coding option, in particular to the  $2 \times \text{REF}_{\text{IN}}$  input range with  $-\text{REF}_{\text{IN}}$  to  $+\text{REF}_{\text{IN}}$  biased about the  $\text{REF}_{\text{IN}}$  point. It is the deviation of the first code transition (100 . . . 000) to (100 . . . 001) from the ideal (i.e.,  $-\text{REF}_{\text{IN}} + 1 \text{ LSB}$ ) after the Zero Code Error has been adjusted out.

### Negative Gain Error Match

This is the difference in Negative Gain Error between any two channels.

### Channel-to-Channel Isolation

Channel-to-Channel Isolation is a measure of the level of crosstalk between channels. It is measured by applying a full-scale 400 kHz sine wave signal to all seven nonselected input channels and determining how much that signal is attenuated in the selected channel with a 50 kHz signal. The figure is given worst case across all eight channels for the AD7927.

### PSR (Power Supply Rejection)

Variations in power supply will affect the full-scale transition, but not the converter's linearity. Power supply rejection is the maximum change in full-scale transition point due to a change in power supply voltage from the nominal value. See Typical Performance Characteristics.

### Track-and-Hold Acquisition Time

The track-and-hold amplifier returns into track mode at the end of conversion. Track-and-hold acquisition time is the time required for the output of the track-and-hold amplifier to reach its final value, within  $\pm 1 \text{ LSB}$ , after the end of conversion.

### Signal-to-(Noise + Distortion) Ratio

This is the measured ratio of signal-to-(noise + distortion) at the output of the A/D converter. The signal is the rms amplitude of the fundamental. Noise is the sum of all nonfundamental signals up to half the sampling frequency ( $f_s/2$ ), excluding dc. The ratio is dependent on the number of quantization levels in the digitization process; the more levels, the smaller the quantization noise. The theoretical signal-to-(noise + distortion) ratio for an ideal N-bit converter with a sine wave input is given by:

$$\text{Signal-to-(Noise + Distortion)} = (6.02N + 1.76) \text{ dB}$$

Thus for a 12-bit converter, this is 74 dB.

### Total Harmonic Distortion

Total harmonic distortion (THD) is the ratio of the rms sum of harmonics to the fundamental. For the AD7927, it is defined as:

$$\text{THD(dB)} = 20 \log \frac{\sqrt{V_2^2 + V_3^2 + V_4^2 + V_5^2 + V_6^2}}{V_1}$$

where  $V_1$  is the rms amplitude of the fundamental and  $V_2$ ,  $V_3$ ,  $V_4$ ,  $V_5$ , and  $V_6$  are the rms amplitudes of the second through the sixth harmonics.



# AD7927—Typical Performance Characteristics

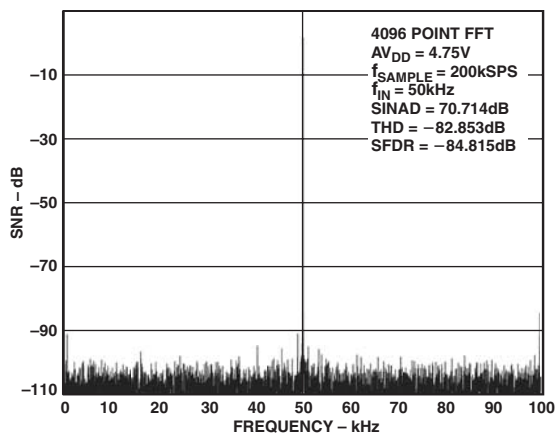
## PERFORMANCE CURVES

TPC 1 shows a typical FFT plot for the AD7927 at 200 kSPS sample rate and 50 kHz input frequency. TPC 2 shows the signal-to-(noise + distortion) ratio performance versus input frequency for various supply voltages while sampling at 200 kSPS with an SCLK of 20 MHz.

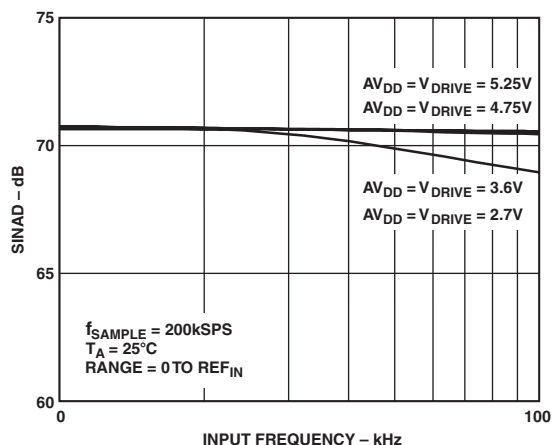
TPC 3 shows the power supply rejection ratio versus supply ripple frequency for the AD7927 with no decoupling. The power supply rejection ratio is defined as the ratio of the power in the ADC output at full-scale frequency  $f_i$  to the power of a 200 mV p-p sine wave applied to the ADC  $AV_{DD}$  supply of frequency  $f_s$ :

$$PSRR(dB) = 10 \log(P_f/P_{f_s})$$

$P_f$  is equal to the power at frequency  $f$  in ADC output;  $P_{f_s}$  is equal to the power at frequency  $f_s$  coupled onto the ADC  $AV_{DD}$  supply. Here a 200 mV p-p sine wave is coupled onto the  $AV_{DD}$  supply.



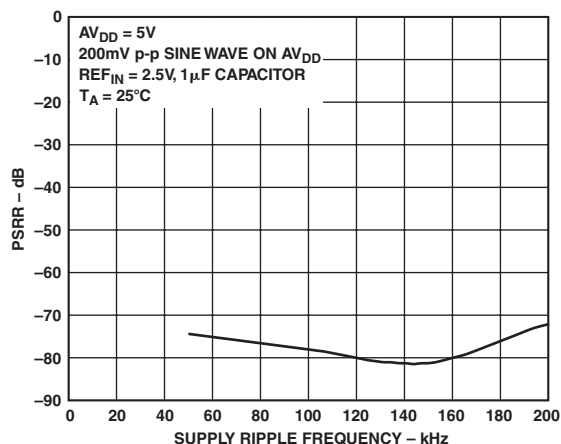
TPC 1. Dynamic Performance at 200 kSPS



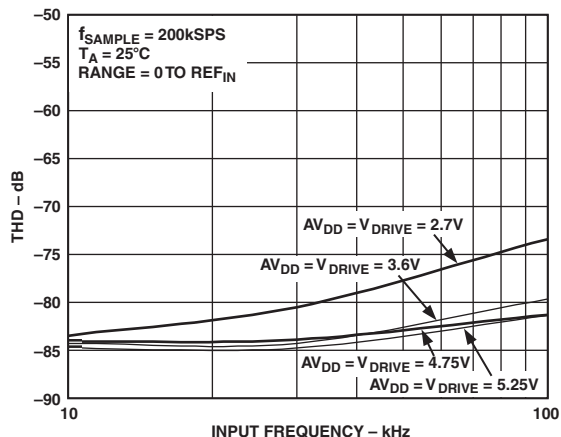
TPC 2. SINAD vs. Analog Input Frequency for Various Supply Voltages at 200 kSPS

TPC 4 shows a graph of total harmonic distortion versus analog input frequency for various supply voltages, while TPC 5 shows a graph of total harmonic distortion versus analog input frequency for various source impedances. See the Analog Input section.

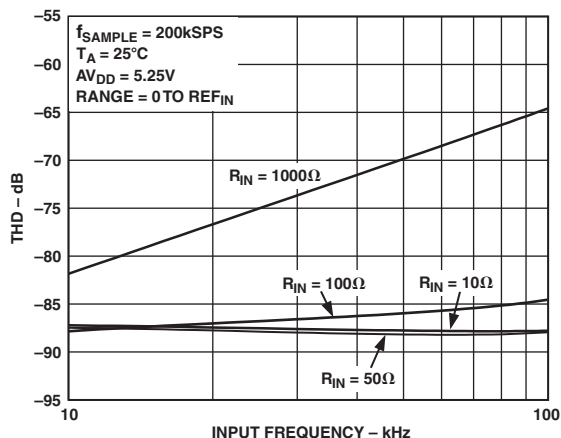
TPC 6 and TPC 7 show typical INL and DNL plots for the AD7927.



TPC 3. PSRR vs. Supply Ripple Frequency

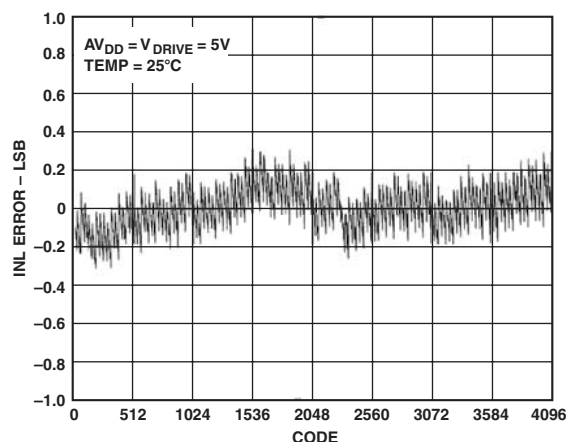


TPC 4. THD vs. Analog Input Frequency for Various Supply Voltages at 200 kSPS

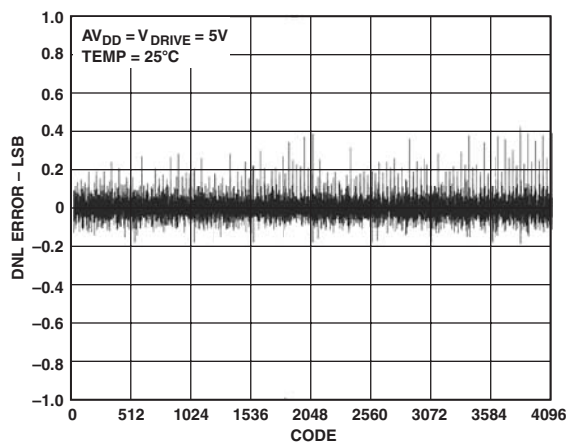


TPC 5. THD vs. Analog Input Frequency for Various Source Impedances





TPC 6. Typical INL



TPC 7. Typical DNL

## CONTROL REGISTER

The Control Register on the AD7927 is a 12-bit, write-only register. Data is loaded from the DIN pin of the AD7927 on the falling edge of SCLK. The data is transferred on the DIN line at the same time that the conversion result is read from the part. The data transferred on the DIN line corresponds to the AD7927 configuration for the next conversion. This requires 16 serial clocks for every data transfer. Only the information provided on the first 12 falling clock edges (after  $\overline{CS}$  falling edge) is loaded to the Control Register. MSB denotes the first bit in the data stream. The bit functions are outlined in Table I.

Table I. Control Register Bit Functions

MSB						LSB					
WRITE	SEQ	DONTC	ADD2	ADD1	ADD0	PM1	PM0	SHADOW	DONTC	RANGE	CODING

Bit	Mnemonic	Comment
11	WRITE	The value written to this bit of the Control Register determines whether the following 11 bits will be loaded to the Control Register. If this bit is a 1, the following 11 bits will be written to the Control Register; if it is a 0, then the remaining 11 bits are not loaded to the Control Register and it remains unchanged.
10	SEQ	The SEQ bit in the Control Register is used in conjunction with the SHADOW bit to control the use of the sequencer function and access the Shadow Register. (See Table IV.)
9	DONTC	Don't Care
8–6	ADD2–ADD0	These three address bits are loaded at the end of the present conversion and select which analog input channel is to be converted in the next serial transfer, or they may select the final channel in a consecutive sequence as described in Table IV. The selected input channel is decoded as shown in Table II. The address bits corresponding to the conversion result are also output on DOUT prior to the 12 bits of data. (See the Serial Interface section.) The next channel to be converted on will be selected by the mux on the 14th SCLK falling edge.
5, 4	PM1, PM0	Power Management Bits. These two bits decode the mode of operation of the AD7927 as shown in Table III.
3	SHADOW	The SHADOW bit in the Control Register is used in conjunction with the SEQ bit to control the use of the sequencer function and access the Shadow Register. (See Table IV.)
2	DONTC	Don't Care
1	RANGE	This bit selects the analog input range to be used on the AD7927. If it is set to 0, the analog input range will extend from 0 V to $2 \times \text{REF}_{\text{IN}}$ . If it is set to 1, the analog input range will extend from 0 V to $\text{REF}_{\text{IN}}$ (for the next conversion). For the 0 V to $2 \times \text{REF}_{\text{IN}}$ range, $\text{AV}_{\text{DD}} = 4.75 \text{ V to } 5.25 \text{ V}$ .
0	CODING	This bit selects the type of output coding the AD7927 will use for the conversion result. If this bit is set to 0, the output coding for the part will be twos complement. If this bit is set to 1, the output coding from the part will be straight binary (for the next conversion).

# AD7927

**Table II. Channel Selection**

ADD2	ADD1	ADD0	Analog Input Channel
0	0	0	V <sub>IN</sub> 0
0	0	1	V <sub>IN</sub> 1
0	1	0	V <sub>IN</sub> 2
0	1	1	V <sub>IN</sub> 3
1	0	0	V <sub>IN</sub> 4
1	0	1	V <sub>IN</sub> 5
1	1	0	V <sub>IN</sub> 6
1	1	1	V <sub>IN</sub> 7

**Table III. Power Mode Selection**

PM1	PM0	Mode
1	1	<b>Normal Operation.</b> In this mode, the AD7927 remains in full power mode, regardless of the status of any of the logic inputs. This mode allows the fastest possible throughput rate from the AD7927.
1	0	<b>Full Shutdown.</b> In this mode, the AD7927 is in full shutdown mode with all circuitry on the AD7927 powering down. The AD7927 retains the information in the Control Register while in full shutdown. The part remains in full shutdown until these bits are changed.
0	1	<b>Auto Shutdown.</b> In this mode, the AD7927 automatically enters full shutdown mode at the end of each conversion when the Control Register is updated. Wake-up time from full shutdown is 1 $\mu$ s and the user should ensure that 1 $\mu$ s has elapsed before attempting to perform a valid conversion on the part in this mode.
0	0	<b>Invalid Selection.</b> This configuration is not allowed.

## SEQUENCER OPERATION

The configuration of the SEQ and SHADOW bits in the Control Register allows the user to select a particular mode of operation of the sequencer function. Table IV outlines the four modes of operation of the sequencer.

**Table IV. Sequence Selection**

SEQ	SHADOW	Sequence Type
0	0	This configuration means that the sequence function is not used. The analog input channel selected for each individual conversion is determined by the contents of the channel address bits ADD0 through ADD2 in each prior write operation. This mode of operation reflects the traditional operation of a multichannel ADC, without the sequencer function being used, where each write to the AD7927 selects the next channel for conversion. (See Figure 2.)
0	1	This configuration selects the Shadow Register for programming. The following write operation will load the contents of the Shadow Register. This will program the sequence of channels to be converted on continuously with each successive valid $\overline{CS}$ falling edge. (See Shadow Register, Table V, and Figure 3.) The channels selected need not be consecutive.
1	0	If the SEQ and SHADOW bits are set in this way, the sequence function will not be interrupted upon completion of the WRITE operation. This allows other bits in the Control Register to be altered between conversions while in a sequence, without terminating the cycle.
1	1	This configuration is used in conjunction with the channel address bits ADD2 to ADD0 to program continuous conversions on a consecutive sequence of channels from Channel 0 to a selected final channel as determined by the channel address bits in the Control Register. (See Figure 4.)

## SHADOW REGISTER

The Shadow Register on the AD7927 is a 16-bit, write-only register. Data is loaded from the DIN pin of the AD7927 on the falling edge of SCLK. The data is transferred on the DIN line at the same time that a conversion result is read from the part. This requires 16 serial clock falling edges for the data transfer. The information is clocked into the Shadow Register, provided that the SEQ and SHADOW bits were set to 0,1, respectively, in the previous write to the Control Register. MSB denotes the first bit in the data stream. Each bit represents an analog input from Channel 0 to Channel 7. Through programming the Shadow Register, two sequences of channels may be selected, through

which the AD7927 will cycle with each consecutive conversion after the write to the Shadow Register. Sequence One will be performed first and then Sequence Two. If the user does not wish to preform a second sequence option, then all 0s must be written to the last eight LSBs of the Shadow Register. To select a sequence of channels, the associated channel bit must be set for each analog input. The AD7927 will continuously cycle through the selected channels in ascending order, beginning with the lowest channel, until a write operation occurs (i.e., the WRITE bit is set to 1) with the SEQ and SHADOW bits configured in any way except 1,0. (See Table IV.) The bit functions are outlined in Table V.

Table V. Shadow Register Bit Functions

MSB								LSB							
V <sub>IN0</sub>	V <sub>IN1</sub>	V <sub>IN2</sub>	V <sub>IN3</sub>	V <sub>IN4</sub>	V <sub>IN5</sub>	V <sub>IN6</sub>	V <sub>IN7</sub>	V <sub>IN0</sub>	V <sub>IN1</sub>	V <sub>IN2</sub>	V <sub>IN3</sub>	V <sub>IN4</sub>	V <sub>IN5</sub>	V <sub>IN6</sub>	V <sub>IN7</sub>
-----SEQUENCE ONE-----								-----SEQUENCE TWO-----							

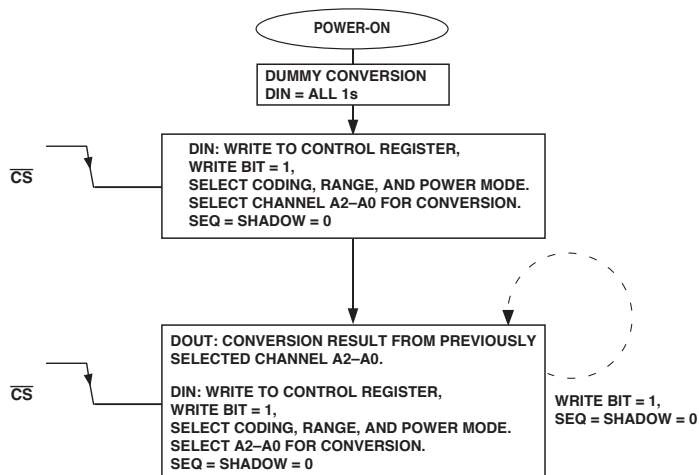


Figure 2. SEQ Bit = 0, SHADOW Bit = 0 Flowchart

Figure 2 reflects the traditional operation of a multichannel ADC, where each serial transfer selects the next channel for conversion. In this mode of operation, the sequencer function is not used.

Figure 3 shows how to program the AD7927 to continuously convert on a particular sequence of channels. To exit this mode of operation and revert back to the traditional mode of operation of a multichannel ADC (as outlined in Figure 2), ensure that the WRITE bit = 1 and the SEQ = SHADOW = 0 on the next serial transfer. Figure 4 shows how a sequence of consecutive channels can be converted on without having to program the Shadow Register or write to the part on each serial transfer. Again, to exit this mode of operation and revert back to the traditional mode of operation of a multichannel ADC (as outlined in Figure 2), ensure the WRITE bit = 1 and the SEQ = SHADOW = 0 on the next serial transfer.

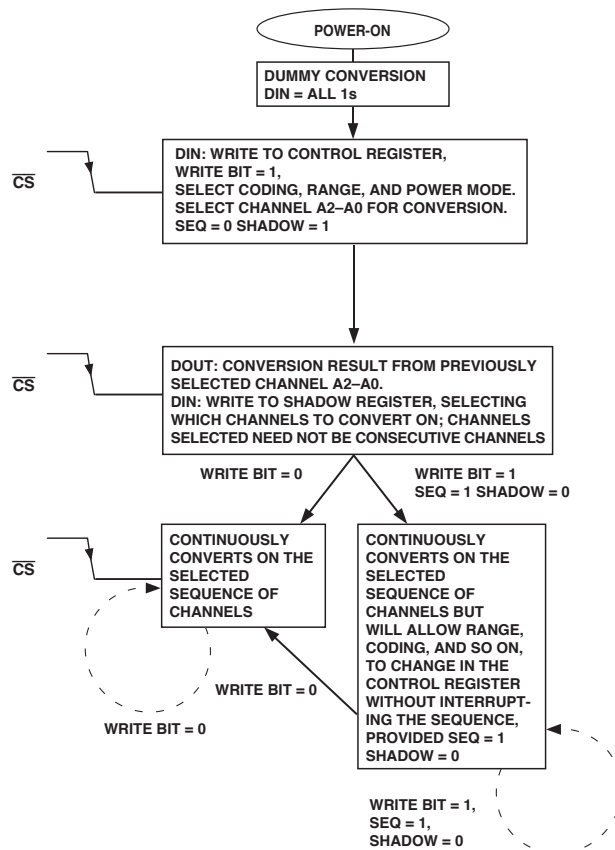


Figure 3. SEQ Bit = 0, SHADOW Bit = 1 Flowchart

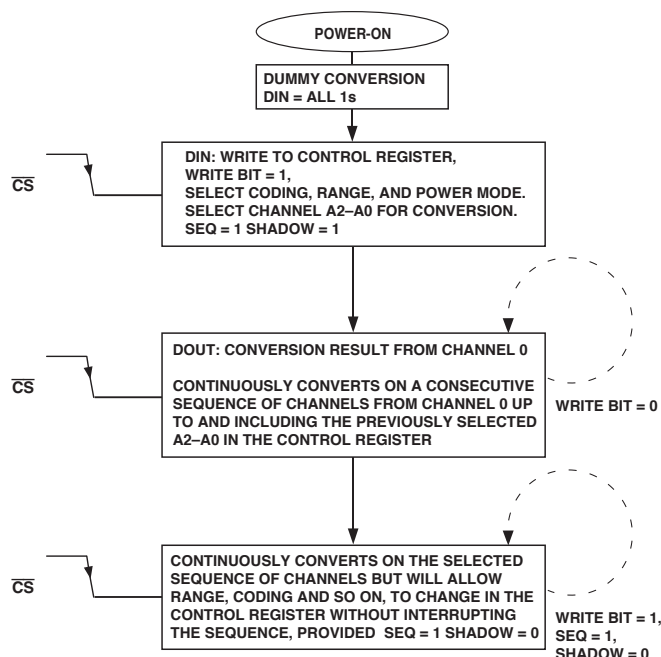


Figure 4. SEQ Bit = 1, SHADOW Bit = 1 Flowchart

## CIRCUIT INFORMATION

The AD7927 is a high speed, 8-channel, 12-bit, single supply, A/D converter. The part can be operated from a 2.7 V to 5.25 V supply. When operated from either a 5 V or 3 V supply, the AD7927 is capable of throughput rates of 200 kSPS. The conversion time may be as short as 800 ns when provided with a 20 MHz clock.

The AD7927 provides the user with an on-chip track-and-hold, A/D converter, and a serial interface housed in a 20-lead TSSOP package. The AD7927 has eight single-ended input channels with a channel sequencer, allowing the user to select a channel sequence through which the ADC can cycle with each consecutive  $\overline{CS}$  falling edge. The serial clock input accesses data from the part, controls the transfer of data written to the ADC, and provides the clock source for the successive-approximation A/D converter. The analog input range for the AD7927 is 0 V to  $REF_{IN}$  or 0 V to  $2 \times REF_{IN}$ , depending on the status of Bit 1 in the Control Register. For the 0 to  $2 \times REF_{IN}$  range, the part must be operated from a 4.75 V to 5.25 V supply.

The AD7927 provides flexible power management options to allow the user to achieve the best power performance for a given throughput rate. These options are selected by programming the Power Management bits, PM1 and PM0, in the Control Register.

## CONVERTER OPERATION

The AD7927 is a 12-bit successive approximation analog-to-digital converter based around a capacitive DAC. The AD7927 can convert analog input signals in the range 0 V to  $REF_{IN}$  or 0 V to  $2 \times REF_{IN}$ . Figures 5 and 6 show simplified schematics of the ADC. The ADC is comprised of Control Logic, SAR, and a Capacitive DAC that are used to add and subtract fixed amounts of charge from the sampling capacitor to bring the comparator back into a balanced condition. Figure 5 shows the ADC during its acquisition phase. SW2 is closed and SW1 is in position A. The comparator is held in a balanced condition and the sampling capacitor acquires the signal on the selected  $V_{IN}$  channel.

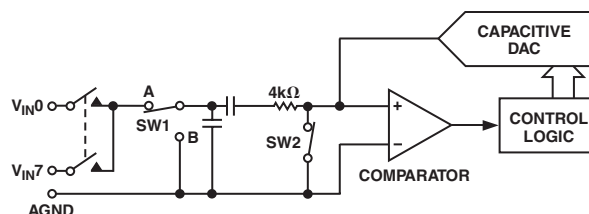


Figure 5. ADC Acquisition Phase

When the ADC starts a conversion (see Figure 6), SW2 will open and SW1 will move to position B, causing the comparator to become unbalanced. The Control Logic and the Capacitive DAC are used to add and subtract fixed amounts of charge from the sampling capacitor to bring the comparator back into a balanced condition. When the comparator is rebalanced, the conversion is complete. The Control Logic generates the ADC output code. Figures 8 and 9 show the ADC transfer functions.

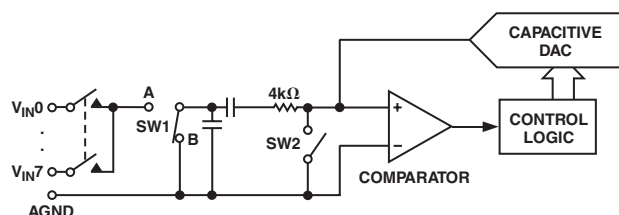


Figure 6. ADC Conversion Phase

## Analog Input

Figure 7 shows an equivalent circuit of the analog input structure of the AD7927. The two diodes D1 and D2 provide ESD protection for the analog inputs. Care must be taken to ensure that the analog input signal never exceeds the supply rails by more than 300 mV. This will cause these diodes to become forward biased and start conducting current into the substrate. 10 mA is the maximum current these diodes can conduct without causing irreversible damage to the part. The capacitor C1 in Figure 7 is typically about 4 pF and can primarily be attributed to pin capacitance. The resistor R1 is a lumped component made up of the on resistance of a switch (track-and-hold switch) and also includes the on resistance of the input multiplexer. The total resistance is typically about 400 Ω. The capacitor C2 is the ADC sampling capacitor and has a capacitance of 30 pF typically. For ac applications, removing high frequency components from the analog input signal is recommended by use of an RC low-pass filter on the relevant analog input pin. In applications where harmonic distortion and signal to noise ratio are critical, the analog input should be driven from a low impedance source. Large source impedances will significantly affect the ac performance of the ADC. This may necessitate the use of an input buffer amplifier. The choice of the op amp will be a function of the particular application.

When no amplifier is used to drive the analog input, the source impedance should be limited to low values. The maximum source impedance will depend on the amount of total harmonic distortion (THD) that can be tolerated. The THD will increase as the source impedance increases, and performance will degrade. (See TPC 5.)

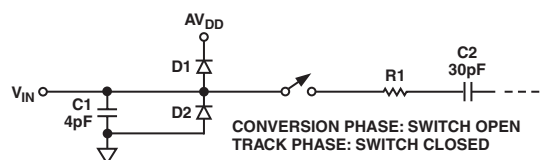
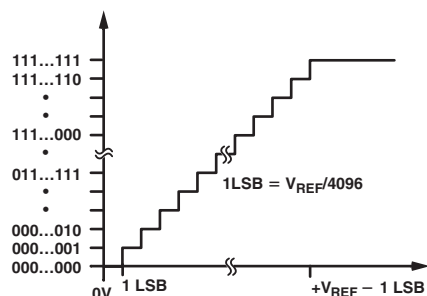


Figure 7. Equivalent Analog Input Circuit

## ADC TRANSFER FUNCTION

The output coding of the AD7927 is either straight binary or twos complement, depending on the status of the LSB in the Control Register. The designed code transitions occur at successive LSB values (i.e., 1 LSB, 2 LSBs, and so forth). The LSB

size is  $REF_{IN}/4096$  for the AD7927. The ideal transfer characteristic for the AD7927 when straight binary coding is selected is shown in Figure 8, and the ideal transfer characteristic for the AD7927 when twos complement coding is selected is shown in Figure 9.



NOTE:  $V_{REF}$  IS EITHER  $REF_{IN}$  OR  $2 \times REF_{IN}$

Figure 8. Straight Binary Transfer Characteristic

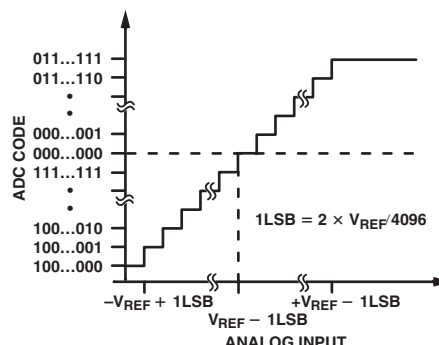


Figure 9. Twos Complement Transfer Characteristic with  $REF_{IN} \pm REF_{IN}$  Input Range

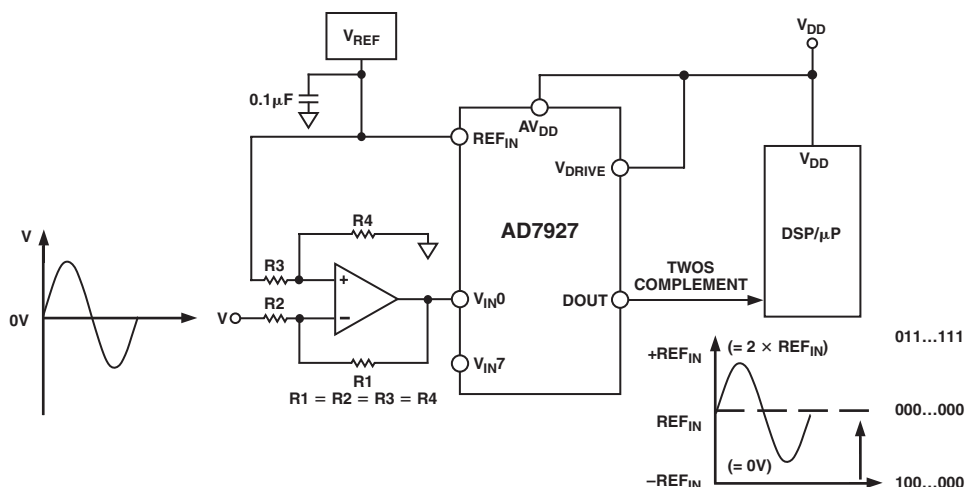


Figure 10. Handling Bipolar Signals

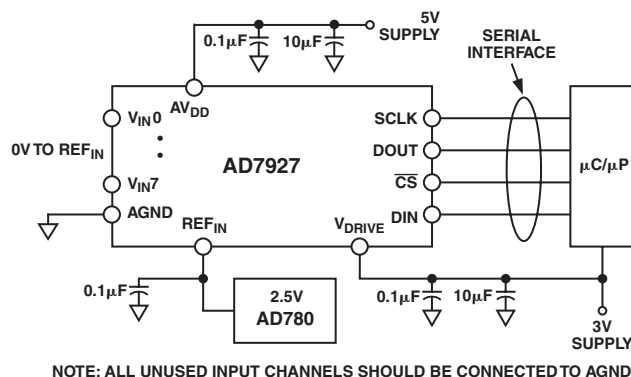
## Handling Bipolar Input Signals

Figure 10 shows how useful the combination of the  $2 \times REF_{IN}$  input range and the twos complement output coding scheme is for handling bipolar input signals. If the bipolar input signal is biased about  $REF_{IN}$  and twos complement output coding is selected, then  $REF_{IN}$  becomes the zero code point,  $-REF_{IN}$  is negative full scale and  $+REF_{IN}$  becomes positive full scale, with a dynamic range of  $2 \times REF_{IN}$ .

## TYPICAL CONNECTION DIAGRAM

Figure 11 shows a typical connection diagram for the AD7927. In this setup, the AGND pin is connected to the analog ground plane of the system. In Figure 11,  $REF_{IN}$  is connected to a decoupled 2.5 V supply from a reference source, the AD780, to provide an analog input range of 0 V to 2.5 V (if RANGE bit is 1) or 0 V to 5 V (if RANGE bit is 0). Although the AD7927 is connected to a  $AV_{DD}$  of 5 V, the serial interface is connected to a 3 V microprocessor. The  $V_{DRIVE}$  pin of the AD7927 is connected to the same 3 V supply of the microprocessor to allow a 3 V logic interface (see the Digital Inputs section). The conversion result is output in a 16-bit word. This 16-bit data stream consists of one

leading zero, three address bits indicating which channel the conversion result corresponds to, followed by the 12 bits of conversion data. For applications where power consumption is of concern, the power-down modes should be used between conversions or bursts of several conversions to improve power performance. (See the Modes of Operation section.)



NOTE: ALL UNUSED INPUT CHANNELS SHOULD BE CONNECTED TO AGND

Figure 11. Typical Connection Diagram



# AD7927

## Analog Input Selection

Any one of eight analog input channels may be selected for conversion by programming the multiplexer with the address bits ADD2 through ADD0 in the Control Register. The channel configurations are shown in Table II.

The AD7927 may also be configured to automatically cycle through a number of channels as selected. The sequencer feature is accessed via the SEQ and SHADOW bits in the Control Register (see Table IV). The AD7927 can be programmed to continuously convert on a selection of channels in ascending order. The analog input channels to be converted on are selected through programming the relevant bits in the Shadow Register (see Table V). The next serial transfer will then act on the sequence programmed by executing a conversion on the lowest channel in the selection. The next serial transfer will result in the conversion on the next highest channel in the sequence, and so on.

It is not necessary to write to the Control Register once a sequencer operation has been initiated. The WRITE bit must be set to zero or the DIN line tied low to ensure that the Control Register is not accidentally overwritten, or the sequence operation interrupted. If the Control Register is written to at any time during the sequence, the user must ensure that the SEQ and SHADOW bits are set to 1,0 to avoid interrupting the automatic conversion sequence. This pattern will continue until such time as the AD7927 is written to and the SEQ and SHADOW bits are configured with any bit combination except 1,0. On completion of the sequence, the AD7927 sequencer will return to the first selected channel in the Shadow Register and commence the sequence again.

Rather than selecting a particular sequence of channels, a number of consecutive channels beginning with Channel 0 may also be programmed via the Control Register alone without needing to write to the Shadow Register. This is possible if the SEQ and SHADOW bits are set to 1,1. The channel address bits ADD2 through ADD0 will then determine the final channel in the consecutive sequence. The next conversion will be on Channel 0, then Channel 1, and so on until the channel selected via the address bits ADD2 through ADD0 is reached. The cycle will begin again on the next serial transfer provided the WRITE bit is set to low, or if high, that the SEQ and SHADOW bits are set to 1,0; then the ADC will continue its preprogrammed automatic sequence uninterrupted.

Regardless of which channel selection method is used, the 16-bit word output from the AD7927 during each conversion will always contain one leading zero, three channel address bits that the conversion result corresponds to, followed by the 12-bit conversion result. (See the Serial Interface section.)

## Digital Inputs

The digital inputs applied to the AD7927 are not limited by the maximum ratings that limit the analog inputs. Instead, the digital inputs applied can go to 7 V and are not restricted by the  $AV_{DD} + 0.3$  V limit as on the analog inputs.

Another advantage of SCLK, DIN, and  $\overline{CS}$  not being restricted by the  $AV_{DD} + 0.3$  V limit is that possible power supply sequencing issues are avoided. If  $\overline{CS}$ , DIN, or SCLK are applied before  $AV_{DD}$ , there is no risk of latch-up as there would be on the analog inputs if a signal greater than 0.3 V was applied prior to  $AV_{DD}$ .

## $V_{DRIVE}$

The AD7927 also has the  $V_{DRIVE}$  feature.  $V_{DRIVE}$  controls the voltage at which the serial interface operates.  $V_{DRIVE}$  allows the ADC

to easily interface to both 3 V and 5 V processors. For example, if the AD7927 were operated with an  $AV_{DD}$  of 5 V, the  $V_{DRIVE}$  pin could be powered from a 3 V supply. The AD7927 has a larger dynamic range with an  $AV_{DD}$  of 5 V while still being able to interface to 3 V processors. Care should be taken to ensure  $V_{DRIVE}$  does not exceed  $AV_{DD}$  by more than 0.3 V. (See Absolute Maximum Ratings.)

## The Reference

An external reference source should be used to supply the 2.5 V reference to the AD7927. Errors in the reference source will result in gain errors in the AD7927 transfer function and will add to the specified full-scale errors of the part. A capacitor of at least 0.1  $\mu$ F should be placed on the  $REF_{IN}$  pin. Suitable reference sources for the AD7927 include the AD780, REF 193, and the AD1582.

If 2.5 V is applied to the  $REF_{IN}$  pin, the analog input range can be either 0 V to 2.5 V or 0 V to 5 V, depending on the setting of the RANGE bit in the Control Register.

## MODES OF OPERATION

The AD7927 has a number of different modes of operation, which are designed to provide flexible power management options. These options can be chosen to optimize the power dissipation/throughput rate ratio for differing application requirements. The mode of operation of the AD7927 is controlled by the power management bits, PM1 and PM0, in the Control Register, as detailed in Table III. When power supplies are first applied to the AD7927, care should be taken to ensure that the part is placed in the required mode of operation. (See the Powering Up the AD7927 section.)

### Normal Mode (PM1 = PM0 = 1)

This mode is intended for the fastest throughput rate performance as the user does not have to worry about any power-up times with the AD7927 remaining fully powered at all times. Figure 12 shows the general diagram of the operation of the AD7927 in this mode.

The conversion is initiated on the falling edge of  $\overline{CS}$  and the track and hold will enter hold mode as described in the Serial Interface section. The data presented to the AD7927 on the DIN line during the first 12 clock cycles of the data transfer are loaded into the Control Register (provided WRITE bit is 1). If data is to be written to the Shadow Register (SEQ = 0, SHADOW = 1 on previous write), data presented on the DIN line during the first 16 SCLK cycles is loaded into the Shadow Register. The part will remain fully powered up in Normal mode at the end of the conversion as long as PM1 and PM0 are set to 1 in the write transfer during that conversion. To ensure continued operation in Normal mode, PM1 and PM0 are both loaded with 1 on every data transfer. Sixteen serial clock cycles are required to complete the conversion and access the conversion result. The track and hold will go back into track on the 14th SCLK falling edge.  $\overline{CS}$  may then idle high until the next conversion or may idle low until sometime prior to the next conversion (effectively idling  $\overline{CS}$  low).

For specified performance, the throughput rate should not exceed 200 kSPS, which means there should be no less than 5  $\mu$ s between consecutive falling edges of  $\overline{CS}$  when converting. The actual frequency of SCLK used will determine the duration of the conversion within this 5  $\mu$ s cycle; however, once a conversion is complete and  $\overline{CS}$  has returned high, a minimum of the quiet time,  $t_{quiet}$ , must elapse before bringing  $\overline{CS}$  low again to initiate another conversion.

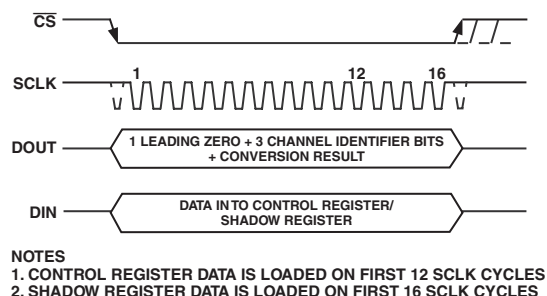


Figure 12. Normal Mode Operation

**Full Shutdown (PM1 = 1, PM0 = 0)**

In this mode, all internal circuitry on the AD7927 is powered down. The part retains information in the Control Register during full shutdown. The AD7927 remains in full shutdown until the power management bits in the Control Register, PM1 and PM0, are changed.

If a write to the Control Register occurs while the part is in full shutdown, with the power management bits changed to PM0 = 1, Normal Mode, the part will begin to power up on the  $\overline{\text{CS}}$  rising edge. The track and hold that was in hold while the part was in full shutdown will return to track on the 14th SCLK falling edge. A full 16 SCLK transfer must occur to ensure the Control Register contents are updated; however, the DOUT line will not be driven during this wake-up transfer.

To ensure that the part is fully powered up,  $t_{\text{POWER UP}}$  should have elapsed before the next  $\overline{\text{CS}}$  falling edge; otherwise, invalid data

will be read if a conversion is initiated before this time. Figure 13 shows the general diagram for this sequence.

**Auto Shutdown (PM1 = 0, PM0 = 1)**

In this mode, the AD7927 automatically enters shutdown at the end of each conversion when the Control Register is updated. When the part is in shutdown, the track and hold is in Hold Mode. Figure 14 shows the general diagram of the operation of the AD7927 in this mode. In Shutdown Mode all internal circuitry on the AD7927 is powered down. The part retains information in the Control Register during shutdown. The AD7927 remains in shutdown until the next  $\overline{\text{CS}}$  falling edge it receives. On this  $\overline{\text{CS}}$  falling edge, the track and hold that was in hold while the part was in shutdown will return to track. Wake-up time from auto shutdown is 1  $\mu\text{s}$  maximum, and the user should ensure that 1  $\mu\text{s}$  has elapsed before attempting a valid conversion. When running the AD7927 with a 20 MHz clock, one dummy 16 SCLK transfer should be sufficient to ensure the part is fully powered up. During this dummy transfer the contents of the Control Register should remain unchanged; therefore the WRITE bit should be 0 on the DIN line.

Depending on the SCLK frequency used, this dummy transfer may affect the achievable throughput rate of the part, with every other data transfer being a valid conversion result. If, for example, the maximum SCLK frequency of 20 MHz was used, the auto shutdown mode could be used at the full throughput rate of 200 kSPS without affecting the throughput rate at all. Only a portion of the cycle time is taken up by the conversion time and the dummy transfer for wake-up.

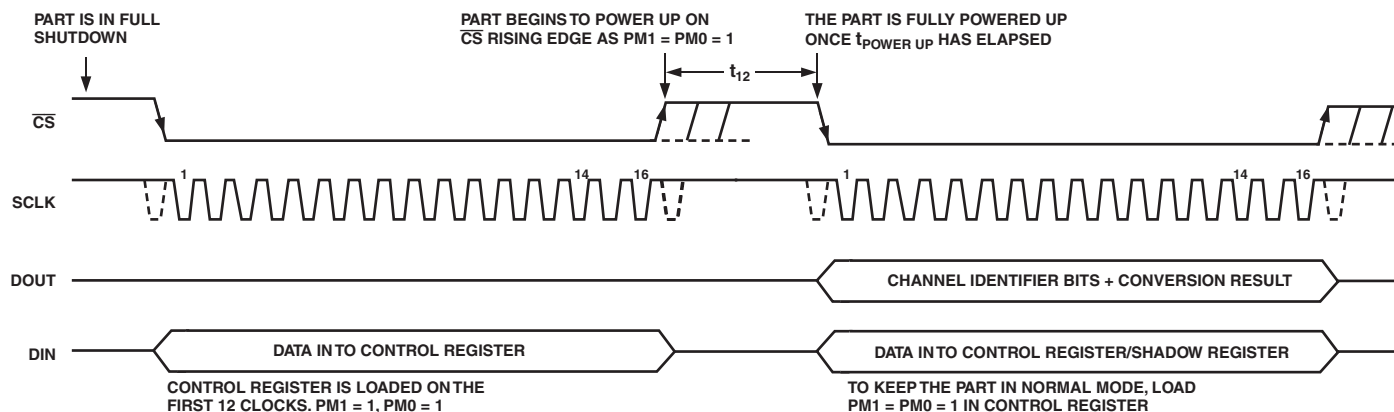


Figure 13. Full Shutdown Mode Operation

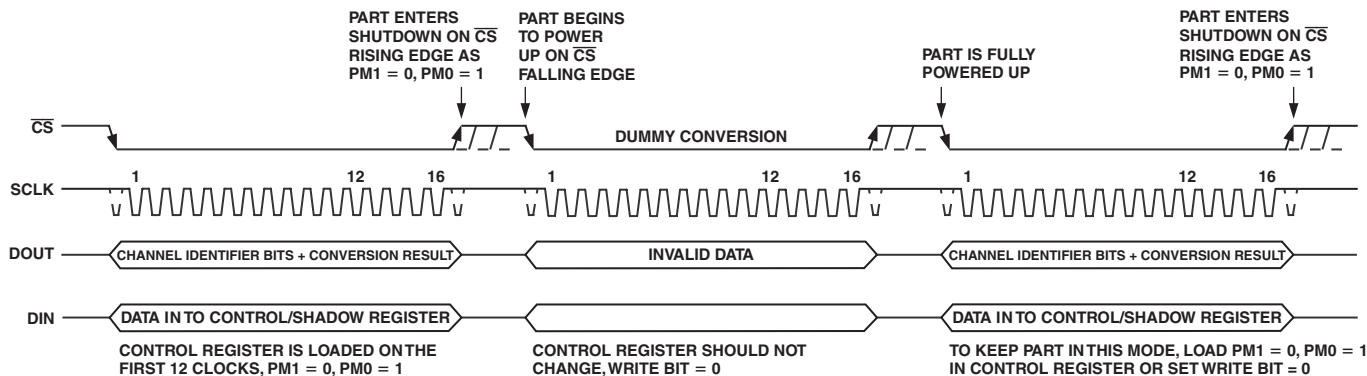


Figure 14. Auto Shutdown Mode Operation



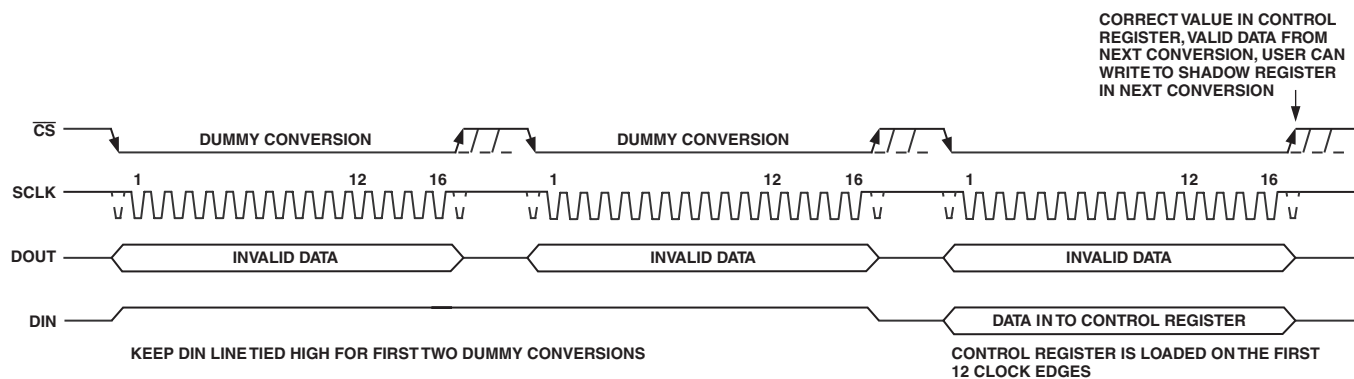


Figure 15. To Place AD7927 into the Required Operating Mode after Supplies Are Applied

In this mode the power consumption of the part is greatly reduced with the part entering shutdown at the end of each conversion. When the Control Register is programmed to move into Auto Shutdown, it does so at the end of the conversion. The user can move the ADC in and out of the low power state by controlling the  $\overline{CS}$  signal.

#### Powering Up the AD7927

When supplies are first applied to the AD7927, the ADC may power up in any of the operating modes of the part. To ensure that the part is placed into the required operating mode, the user should perform a dummy cycle operation as outlined in Figure 15.

The three dummy conversion operation outlined in Figure 15 must be performed to place the part into the Auto Shutdown Mode. The first two conversions of this dummy cycle operation are performed with the DIN line tied high, and for the third conversion of the dummy cycle operation, the user should write the desired Control Register configuration to the AD7927 in order to place the part into the Auto Shutdown mode. On the third  $\overline{CS}$  rising edge after the supplies are applied, the Control Register will contain the correct information and valid data will result from the next conversion.

Therefore, to ensure the part is placed into the correct operating mode, when supplies are first applied to the AD7927, the user must first issue two serial write operations with the DIN line tied high, and on the third conversion cycle the user can then write to the Control Register to place the part into any of the operating modes. The user should not write to the Shadow Register until the fourth conversion cycle after the supplies are applied to the ADC, in order to guarantee the Control Register contains the correct data.

If the user wishes to place the part into either the Normal or Full Shutdown Mode, the second dummy cycle with DIN tied high can be omitted from the three dummy conversion operation outlined in Figure 15.

#### POWER VERSUS THROUGHPUT RATE

In Auto Shutdown Mode, the average power consumption of the ADC may be reduced at any given throughput rate. The power saving will depend on the SCLK frequency used, i.e., conversion time. In some cases where the conversion time is quite a proportion of the cycle time, the throughput rate would need to be reduced in order to take advantage of the power-down modes. Assuming a 20 MHz SCLK is used, the conversion time is

800 ns but the cycle time is 5  $\mu$ s when the sampling rate is at a maximum of 200 kSPS. If the AD7927 is placed into shutdown for the remainder of the cycle time, then on average far less power will be consumed in every cycle compared to leaving the device in Normal Mode. Furthermore, Figure 16 shows how as the throughput rate is reduced, the part remains in its shutdown longer and the average power consumption drops accordingly over time.

For example, if the AD7927 is operated in a continuous sampling mode, with a throughput rate of 200 kSPS and an SCLK of 20 MHz ( $AV_{DD} = 5$  V), and the device is placed in Auto Shutdown Mode i.e., if PM1 = 0 and PM0 = 1, then the power consumption is calculated as follows:

The maximum power dissipation during the conversion time is 13.5 mW ( $I_{DD} = 2.7$  mA max,  $AV_{DD} = 5$  V). If the power-up time from Auto Shutdown is 1  $\mu$ s and the remaining conversion time is another cycle, i.e., 800 ns, the AD7927 can be said to dissipate 13.5 mW for 1.8  $\mu$ s during each conversion cycle. For the remainder of the conversion cycle, 3.2  $\mu$ s, the part remains in Shutdown. The AD7927 can be said to dissipate 2.5  $\mu$ W for the remaining 3.2  $\mu$ s of the conversion cycle. If the throughput rate is 200 kSPS, the cycle time is 5  $\mu$ s and the average power dissipated during each cycle is  $(1.8/5) \times (13.5 \text{ mW}) + (3.2/5) \times (2.5 \mu\text{W}) = 4.8616 \text{ mW}$ .

Figure 16 shows the maximum power versus throughput rate when using the Auto Shutdown mode with 3 V and 5 V supplies.

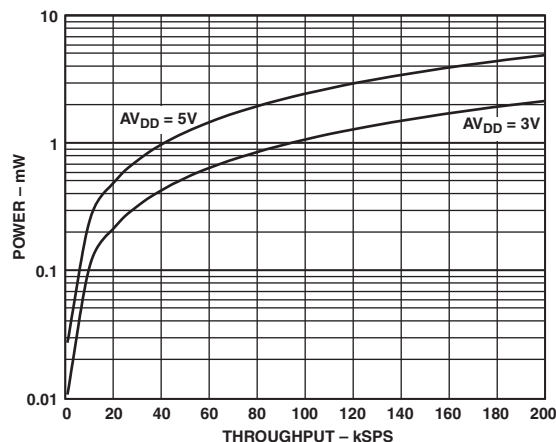


Figure 16. Power vs. Throughput Rate

## SERIAL INTERFACE

Figure 17 shows the detailed timing diagram for serial interfacing to the AD7927. The serial clock provides the conversion clock and also controls the transfer of information to and from the AD7927 during each conversion.

The  $\overline{CS}$  signal initiates the data transfer and conversion process. The falling edge of  $\overline{CS}$  puts the track and hold into hold mode and takes the bus out of three-state; the analog input is sampled at this point. The conversion is also initiated at this point and will require 16 SCLK cycles to complete. The track and hold will go back into track on the 14th SCLK falling edge as shown in Figure 17 at point B, except when the write is to the Shadow Register, in which case the track and hold will not return to track until the rising edge of  $\overline{CS}$ , i.e., point C in Figure 18. On the 16th SCLK falling edge the DOUT line will go back into three-state. If the rising edge of  $\overline{CS}$  occurs before 16 SCLKs have elapsed, the conversion will be terminated and the DOUT line will go back into three-state and the Control Register will not be updated; otherwise DOUT returns to three-state on the 16th SCLK falling edge, as shown in Figure 17. Sixteen serial clock cycles are required to perform the conversion process and to access data from the AD7927. For the AD7927, the 12 bits of data are preceded by a leading zero and the three channel address bits ADD2 to ADD0, identifying which channel the result corresponds to.  $\overline{CS}$  going low provides the leading zero to be read in by the microcontroller or DSP. The three remaining address bits and data bits are then clocked out by subsequent SCLK falling edges beginning with the first address bit ADD2, thus the first falling clock edge on the serial clock has a leading zero provided and also clocks out address bit ADD2. The final bit in the data transfer is valid on the 16th falling edge, having been clocked out on the previous (15th) falling edge.

Writing of information to the Control Register takes place on the first 12 falling edges of SCLK in a data transfer, assuming the MSB, i.e., the WRITE bit, has been set to 1. If the Control Register is programmed to use the Shadow Register, then the writing of information to the Shadow Register will take place on all 16 SCLK falling edges in the next serial transfer as shown for example on the AD7927 in Figure 18. Two sequence options can be programmed in the Shadow Register. If the user does not want to program a second sequence, then the eight LSBs should be filled with zeros. The Shadow Register will be updated upon the rising edge of  $\overline{CS}$  and the track and hold will begin to track the first channel selected in the sequence.

The 16-bit word read from the AD7927 will always contain a leading zero, three channel address bits that the conversion result corresponds to, followed by the 12-bit conversion result.

### Writing Between Conversions

As outlined in the Operating Modes section, not less than 5  $\mu$ s should be left between consecutive valid conversions. However, there is one case where this does not necessarily mean that at least 5  $\mu$ s should always be left between  $\overline{CS}$  falling edges. Consider the case when writing to the AD7927 to power it up from shutdown prior to a valid conversion. The user must write to the part to tell it to power up before it can convert successfully. Once the serial write to power up has finished, one may wish to perform the conversion as soon as possible and not have to wait a further 5  $\mu$ s before bringing  $\overline{CS}$  low for the conversion. In this case, as long as there is a minimum of 5  $\mu$ s between each *valid* conversion, then only the quiet time between the  $\overline{CS}$  rising edge at the end of the write to power up and the next  $\overline{CS}$  falling edge for a valid conversion needs to be met. Figure 19 illustrates this point. Note

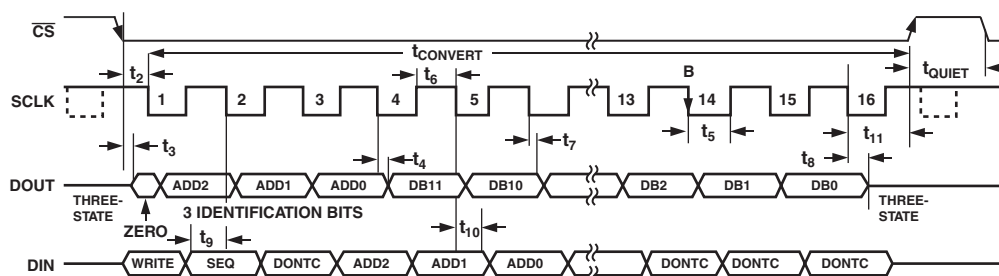


Figure 17. Serial Interface Timing Diagram

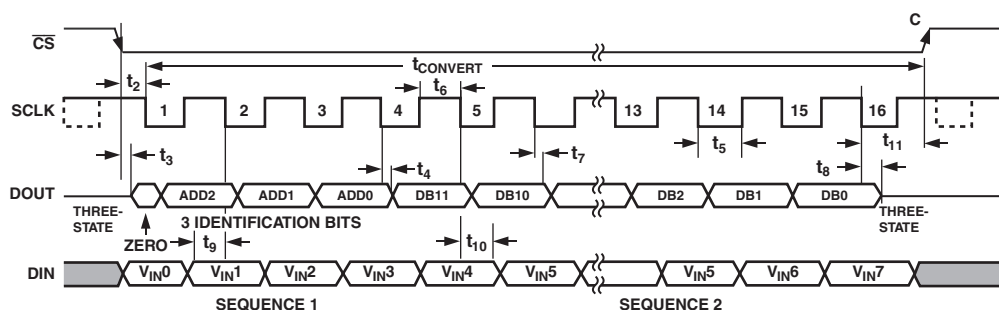


Figure 18. Writing to Shadow Register Timing Diagram

# AD7927

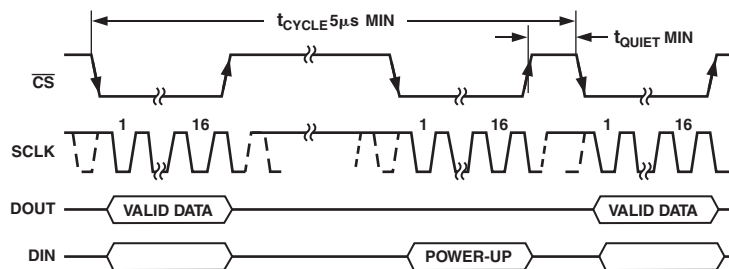


Figure 19. General Timing Diagram

that when writing to the AD7927 between these valid conversions, the DOUT line will not be driven during the extra write operation, as shown in Figure 19.

It is critical that an extra write operation as outlined above is never issued between valid conversions when the AD7927 is executing through a sequence function, as the falling edge of  $\overline{CS}$  in the extra write would move the mux on to the next channel in the sequence. This means when the next valid conversion takes place, a channel result would have been missed.

## MICROPROCESSOR INTERFACING

The serial interface on the AD7927 allows the part to be directly connected to a range of many different microprocessors. This section explains how to interface the AD7927 with some of the more common microcontroller and DSP serial interface protocols.

### AD7927 to TMS320C541

The serial interface on the TMS320C541 uses a continuous serial clock and frame synchronization signals to synchronize the data transfer operations with peripheral devices like the AD7927. The  $\overline{CS}$  input allows easy interfacing between the TMS320C541 and the AD7927 without any glue logic required. The serial port of the TMS320C541 is set up to operate in burst mode with internal CLKX0 (TX serial clock on serial port 0) and FSX0 (TX frame sync from serial port 0). The serial port control register (SPC) must have the following setup: FO = 0, FSM = 1, MCM = 1, and TXM = 1. The connection diagram is shown in Figure 20. It should be noted that for signal processing applications, it is imperative that the frame synchronization signal from the TMS320C541 provides equidistant sampling. The  $V_{DRIVE}$  pin of the AD7927 takes the same supply voltage as that of the TMS320C541. This allows the ADC to operate at a higher voltage than the serial interface, i.e., TMS320C541, if necessary.

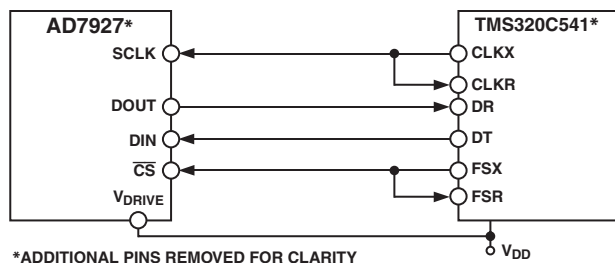


Figure 20. Interfacing to the TMS320C541

### AD7927 to ADSP-21xx

The ADSP-21xx family of DSPs are interfaced directly to the AD7927 without any glue logic required. The  $V_{DRIVE}$  pin of the AD7927 takes the same supply voltage as that of the ADSP-218x. This allows the ADC to operate at a higher voltage than the serial interface, i.e., ADSP-218x, if necessary.

The SPORT0 Control Register should be set up as follows:

TFSW = RFSW = 1, Alternate Framing  
 INVRFS = INVTFS = 1, Active Low Frame Signal  
 DTYPE = 00, Right Justify Data  
 SLEN = 1111, 16-Bit Data-Words  
 ISCLK = 1, Internal Serial Clock  
 TFSR = RFSR = 1, Frame Every Word  
 IRFS = 0  
 ITFS = 1

The connection diagram is shown in Figure 21. The ADSP-218x has the TFS and RFS of the SPORT tied together, with TFS set as an output and RFS set as an input. The DSP operates in Alternate Framing Mode and the SPORT Control Register is set up as described. The frame synchronization signal generated on the TFS is tied to  $\overline{CS}$ , and as with all signal processing applications equidistant sampling is necessary. However, in this example the timer interrupt is used to control the sampling rate of the ADC, and under certain conditions equidistant sampling may not be achieved.

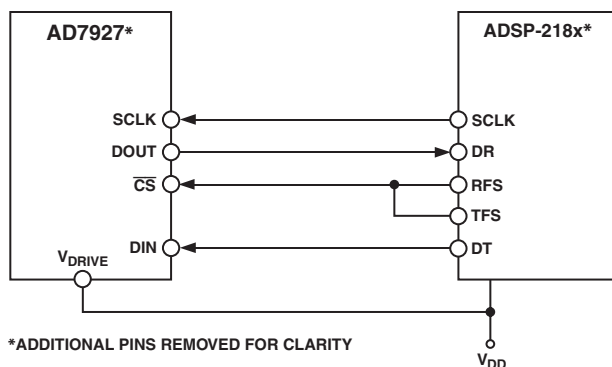


Figure 21. Interfacing to the ADSP-218x

The Timer register, for instance, is loaded with a value that will provide an interrupt at the required sample interval. When an interrupt is received, a value is transmitted with TFS/DT (ADC control word). The TFS is used to control the RFS and therefore the reading of data. The frequency of the serial clock is set in the SCLKDIV Register. When the instruction to transmit with TFS is given (i.e., AX0 = TX0), the state of the SCLK is checked. The DSP will wait until the SCLK has gone High, Low, and High before transmission will start. If the timer and SCLK values are chosen such that the instruction to transmit occurs on or near the rising edge of SCLK, then the data may be transmitted or it may wait until the next clock edge.

For example, if the ADSP-2189 had a 20 MHz crystal such that it had a master clock frequency of 40 MHz, then the master cycle time would be 25 ns. If the SCLKDIV Register is loaded with the value 3, then an SCLK of 5 MHz is obtained and eight master clock periods will elapse for every one SCLK period. Depending on the throughput rate selected, if the Timer Registers are loaded with the value, say 803, 100.5 SCLKs will occur between interrupts and subsequently between transmit instructions. This situation will result in non-equidistant sampling as the transmit instruction is occurring on a SCLK edge. If the number of SCLKs between interrupts is a whole integer figure of N, then equidistant sampling will be implemented by the DSP.

#### AD7927 to DSP563xx

The connection diagram in Figure 22 shows how the AD7927 can be connected to the ESSI (Synchronous Serial Interface) of the DSP563xx family of DSPs from Motorola. Each ESSI (two on board) is operated in Synchronous mode (SYN bit in CRB = 1) with internally generated word length frame sync for both Tx and Rx (bits FSL1 = 0 and FSL0 = 0 in CRB). Normal operation of the ESSI is selected by making MOD = 0 in the CRB. Set the word length to 16 by setting bits WL1 = 1 and WL0 = 0 in CRA. The FSP bit in the CRB should be set to 1 so the frame sync is negative. It should be noted that for signal processing applications, it is imperative that the frame synchronization signal from the DSP563xx provides equidistant sampling.

In the example shown in Figure 22, the serial clock is taken from the ESSI so the SCK0 pin must be set as an output, SCKD = 1. The  $V_{\text{DRIVE}}$  pin of the AD7927 takes the same supply voltage as that of the DSP563xx. This allows the ADC to operate at a higher voltage than the serial interface, i.e., DSP563xx, if necessary.

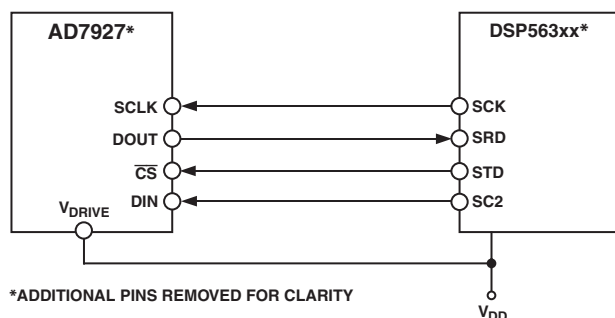


Figure 22. Interfacing to the DSP563xx

## APPLICATION HINTS

### Grounding and Layout

The AD7927 has very good immunity to noise on the power supplies as can be seen by the PSRR vs. Supply Ripple Frequency plot, TPC 3. However, care should still be taken with regard to grounding and layout.

The printed circuit board that houses the AD7927 should be designed such that the analog and digital sections are separated and confined to certain areas of the board. This facilitates the use of ground planes that can be separated easily. A minimum etch technique is generally best for ground planes as it gives the best shielding. All three AGND pins of the AD7927 should be sunk in the AGND plane. Digital and analog ground planes should be joined at only one place. If the AD7927 is in a system where multiple devices require an AGND to DGND connection, the connection should still be made at one point only, a star ground point that should be established as close as possible to the AD7927.

Avoid running digital lines under the device as these will couple noise onto the die. The analog ground plane should be allowed to run under the AD7927 to avoid noise coupling. The power supply lines to the AD7927 should use as large a trace as possible to provide low impedance paths and reduce the effects of glitches on the power supply line. Fast switching signals, like clocks, should be shielded with digital ground to avoid radiating noise to other sections of the board, and clock signals should never be run near the analog inputs. Avoid crossover of digital and analog signals. Traces on opposite sides of the board should run at right angles to each other. This will reduce the effects of feedthrough through the board. A microstrip technique is by far the best but is not always possible with a double-sided board. In this technique, the component side of the board is dedicated to ground planes while signals are placed on the solder side.

Good decoupling is also important. All analog supplies should be decoupled with 10  $\mu\text{F}$  tantalum in parallel with 0.1  $\mu\text{F}$  capacitors to AGND. To achieve the best from these decoupling components, they must be placed as close as possible to the device, ideally right up against the device. The 0.1  $\mu\text{F}$  capacitors should have low Effective Series Resistance (ESR) and Effective Series Inductance (ESI), such as the common ceramic types or surface mount types, which provide a low impedance path to ground at high frequencies to handle transient currents due to internal logic switching.

### Evaluating the AD7927 Performance

The recommended layout for the AD7927 is outlined in the evaluation board for the AD7927. The evaluation board package includes a fully assembled and tested evaluation board, documentation, and software for controlling the board from the PC via the Eval-Board Controller. The Eval-Board Controller can be used in conjunction with the AD7927 Evaluation board as well as many other Analog Devices evaluation boards ending in the CB designator to demonstrate/evaluate the ac and dc performance of the AD7927.

The software allows the user to perform ac (fast Fourier transform) and dc (histogram of codes) tests on the AD7927. The software and documentation are on a CD shipped with the evaluation board.

OUTLINE DIMENSIONS

20-Lead Thin Shrink Small Outline Package [TSSOP]  
(RU-20)

Dimensions shown in millimeters

